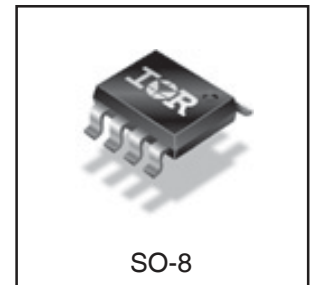
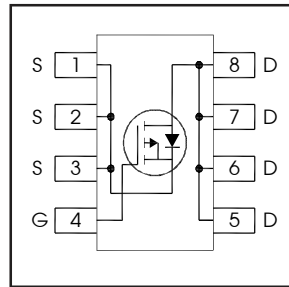


# IRF9393PbF

HEXFET® Power MOSFET

|   |             |           |
|---|-------------|-----------|
| $V_{DS}$                                  | <b>-30</b>  | <b>V</b>  |
| $V_{GS\ max}$                             | <b>±25</b>  | <b>V</b>  |
| $R_{DS(on)\ max}$<br>(@ $V_{GS} = -10V$ ) | <b>19.4</b> | <b>mΩ</b> |
| $I_D$<br>(@ $T_A = 25^\circ C$ )          | <b>-9.2</b> | <b>A</b>  |



## Applications

- Adaptor Input Switch for Notebook PC

## Features and Benefits

### Features

|  |
|--|
| 25V $V_{GS\ max}$  |
| Industry-Standard SO8 Package                                |
| RoHS Compliant Containing no Lead, no Bromide and no Halogen |

### Resulting Benefits

|                               |
|-------------------------------|
| Direct Drive at High $V_{GS}$ |
| Multi-Vendor Compatibility    |
| Environmentally Friendlier    |

| Orderable part number | Package Type | Standard Pack |          | Note |
|-----------------------|--------------|---------------|----------|------|
|                       |              | Form          | Quantity |      |
| IRF9393PbF            | SO8          | Tube/Bulk     | 95       |      |
| IRF9393TRPbF          | SO8          | Tape and Reel | 4000     |      |

## Absolute Maximum Ratings

|                          | Parameter   | Max.         | Units |
|--------------------------|---|--------------|-------|
| $V_{DS}$                 | Drain-to-Source Voltage                             | -30          | V     |
| $V_{GS}$                 | Gate-to-Source Voltage                              | ± 25         |       |
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$            | -9.2         | A     |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$            | -7.3         |       |
| $I_{DM}$                 | Pulsed Drain Current ①                              | -75          |       |
| $P_D @ T_A = 25^\circ C$ | Power Dissipation ④                                 | 2.5          | W     |
| $P_D @ T_A = 70^\circ C$ | Power Dissipation ④                                 | 1.6          |       |
|                          | Linear Derating Factor                              | 0.02         | W/°C  |
| $T_J$<br>$T_{STG}$       | Operating Junction and<br>Storage Temperature Range | -55 to + 150 | °C    |

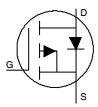
## Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

|                                     | Parameter                            | Min. | Typ.  | Max. | Units | Conditions  |
|-------------------------------------|--------------------------------------|------|-------|------|-------|---|
| B <sub>V</sub> DSS                  | Drain-to-Source Breakdown Voltage    | -30  | —     | —    | V     | V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA                           |
| ΔB <sub>V</sub> DSS/ΔT <sub>J</sub> | Breakdown Voltage Temp. Coefficient  | —    | 0.019 | —    | V/°C  | Reference to 25°C, I <sub>D</sub> = -1mA                                |
| R <sub>DS(on)</sub>                 | Static Drain-to-Source On-Resistance | —    | 13.3  | —    | mΩ    | V <sub>GS</sub> = -20V, I <sub>D</sub> = -9.2A ③                        |
|                                     |                                      | —    | 15.6  | 19.4 |       | V <sub>GS</sub> = -10V, I <sub>D</sub> = -9.2A ③                        |
|                                     |                                      | —    | 25.6  | 32.5 |       | V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -7.5A ③                       |
| V <sub>GS(th)</sub>                 | Gate Threshold Voltage               | -1.3 | -1.8  | -2.4 | V     | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -25μA              |
| ΔV <sub>GS(th)</sub>                | Gate Threshold Voltage Coefficient   | —    | -5.7  | —    | mV/°C |   |
| I <sub>DSS</sub>                    | Drain-to-Source Leakage Current      | —    | —     | -1.0 | μA    | V <sub>DS</sub> = -24V, V <sub>GS</sub> = 0V                            |
|                                     |                                      | —    | —     | -150 |       | V <sub>DS</sub> = -24V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C    |
| I <sub>GSS</sub>                    | Gate-to-Source Forward Leakage       | —    | —     | -10  | μA    | V <sub>GS</sub> = -25V  |
|                                     | Gate-to-Source Reverse Leakage       | —    | —     | 10   |       | V <sub>GS</sub> = 25V   |
| g <sub>fs</sub>                     | Forward Transconductance             | 13   | —     | —    | S     | V <sub>DS</sub> = -10V, I <sub>D</sub> = -7.5A                          |
| Q <sub>g</sub>                      | Total Gate Charge ⑥                  | —    | 14    | —    | nC    | V <sub>DS</sub> = -15V, V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -7.5A |
| Q <sub>g</sub>                      | Total Gate Charge ⑥                  | —    | 25    | 38   | nC    | V <sub>GS</sub> = -10V  |
| Q <sub>gs</sub>                     | Gate-to-Source Charge ⑥              | —    | 3.5   | —    |       | V <sub>DS</sub> = -15V  |
| Q <sub>gd</sub>                     | Gate-to-Drain Charge ⑥               | —    | 6.4   | —    |       | I <sub>D</sub> = -7.5A  |
| R <sub>G</sub>                      | Gate Resistance ⑥                    | —    | 15    | —    | Ω     |   |
| t <sub>d(on)</sub>                  | Turn-On Delay Time                   | —    | 16    | —    | ns    | V <sub>DD</sub> = -15V, V <sub>GS</sub> = -4.5V ③                       |
| t <sub>r</sub>                      | Rise Time                            | —    | 44    | —    |       | I <sub>D</sub> = -1.0A  |
| t <sub>d(off)</sub>                 | Turn-Off Delay Time                  | —    | 55    | —    |       | R <sub>G</sub> = 6.8Ω   |
| t <sub>f</sub>                      | Fall Time                            | —    | 49    | —    |       | See Figs. 20a & 20b   |
| C <sub>iss</sub>                    | Input Capacitance                    | —    | 1110  | —    | pF    | V <sub>GS</sub> = 0V  |
| C <sub>oss</sub>                    | Output Capacitance                   | —    | 230   | —    |       | V <sub>DS</sub> = -25V  |
| C <sub>riss</sub>                   | Reverse Transfer Capacitance         | —    | 160   | —    |       | f = 1.0MHz  |

## Avalanche Characteristics

|                 | Parameter                       | Typ. | Max. | Units |
|-----------------|---------------------------------|------|------|-------|
| E <sub>AS</sub> | Single Pulse Avalanche Energy ② | —    | 100  | mJ    |
| I <sub>AR</sub> | Avalanche Current ①             | —    | -7.5 | A     |

## Diode Characteristics

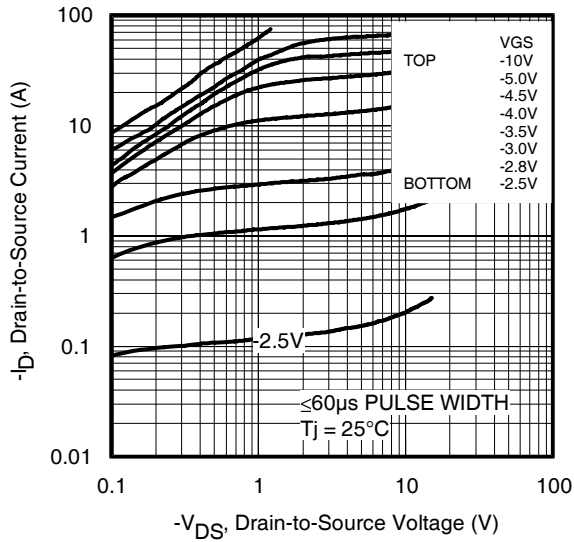
|                 | Parameter                                 | Min. | Typ. | Max. | Units | Conditions   |
|-----------------|---|------|------|------|-------|--|
| I <sub>S</sub>  | Continuous Source Current<br>(Body Diode) | —    | —    | -2.5 | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I <sub>SM</sub> | Pulsed Source Current<br>(Body Diode) ①   | —    | —    | -75  |       |  |
| V <sub>SD</sub> | Diode Forward Voltage                     | —    | —    | -1.2 | V     | T <sub>J</sub> = 25°C, I <sub>S</sub> = -2.5A, V <sub>GS</sub> = 0V ③  |
| t <sub>rr</sub> | Reverse Recovery Time                     | —    | 24   | 36   | ns    | T <sub>J</sub> = 25°C, I <sub>F</sub> = -2.5A, V <sub>DD</sub> = -24V  |
| Q <sub>rr</sub> | Reverse Recovery Charge                   | —    | 15   | 23   | nC    | di/dt = 100A/μs ③  |

## Thermal Resistance

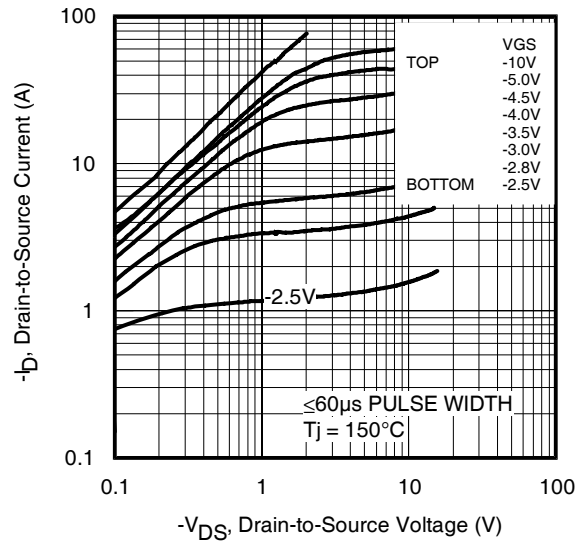
|                  | Parameter                | Typ. | Max. | Units |
|------------------|--------------------------|------|------|-------|
| R <sub>θJL</sub> | Junction-to-Drain Lead ⑤ | —    | 20   | °C/W  |
| R <sub>θJA</sub> | Junction-to-Ambient ④    | —    | 50   |       |

### Notes:

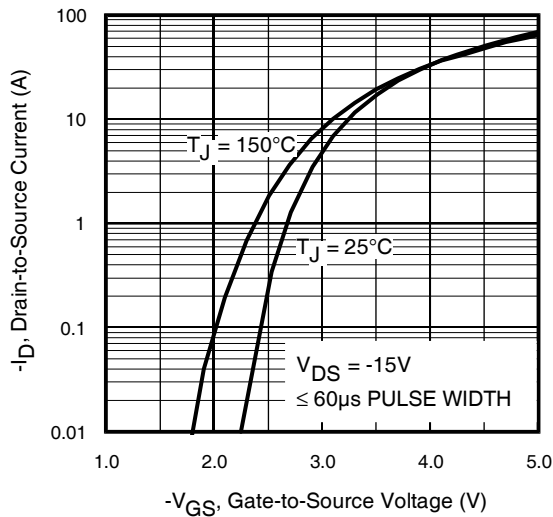
- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting T<sub>J</sub> = 25°C, L = 3.5mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = -7.5A.
- ③ Pulse width ≤ 400μs; duty cycle ≤ 2%.
- ④ When mounted on 1 inch square copper board.
- ⑤ R<sub>θ</sub> is measured at T<sub>J</sub> of approximately 90°C.
- ⑥ For DESIGN AID ONLY, not subject to production testing.



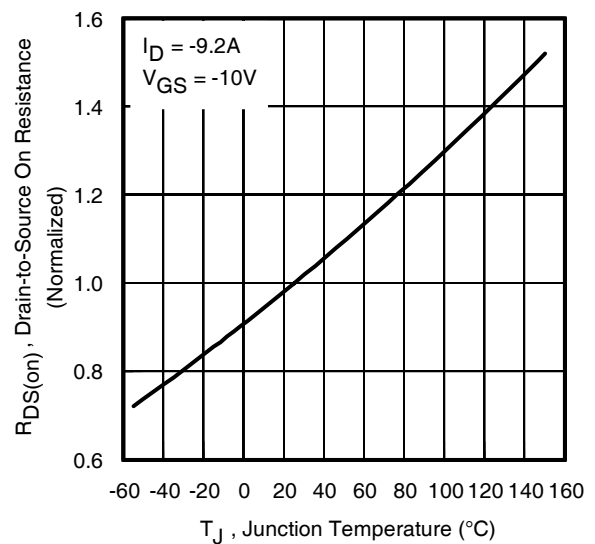
**Fig 1.** Typical Output Characteristics



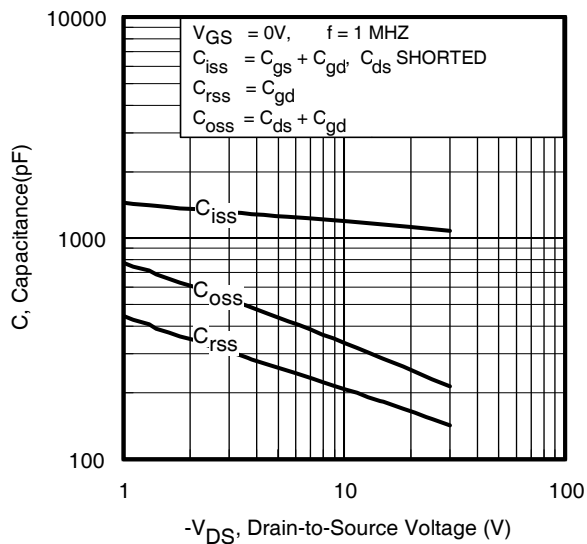
**Fig 2.** Typical Output Characteristics



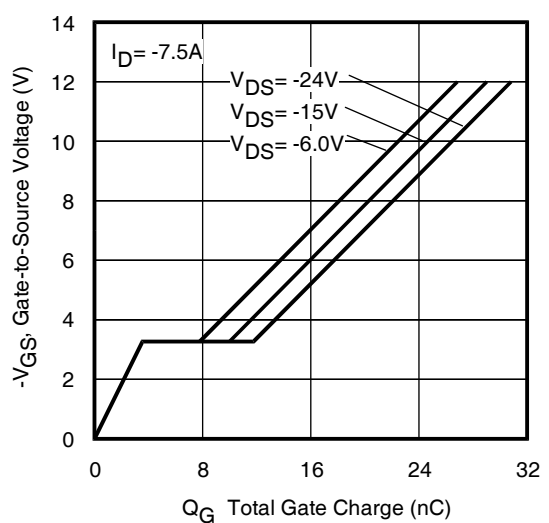
**Fig 3.** Typical Transfer Characteristics



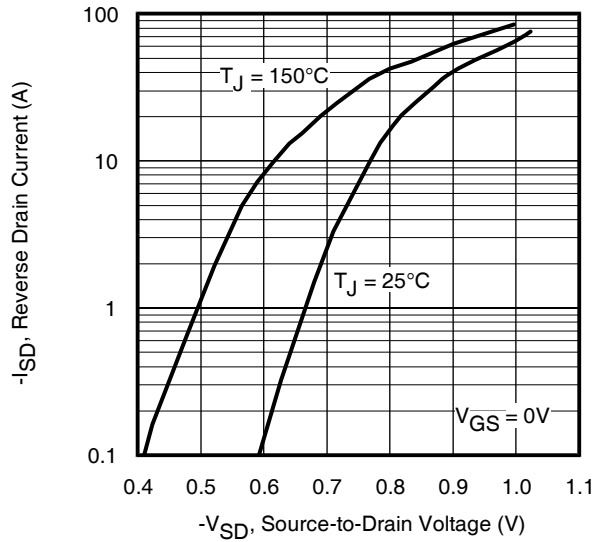
**Fig 4.** Normalized On-Resistance vs. Temperature



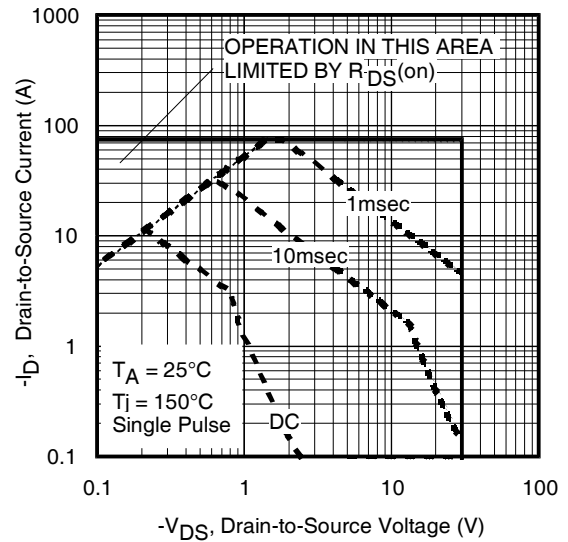
**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage  
[www.irf.com](http://www.irf.com)



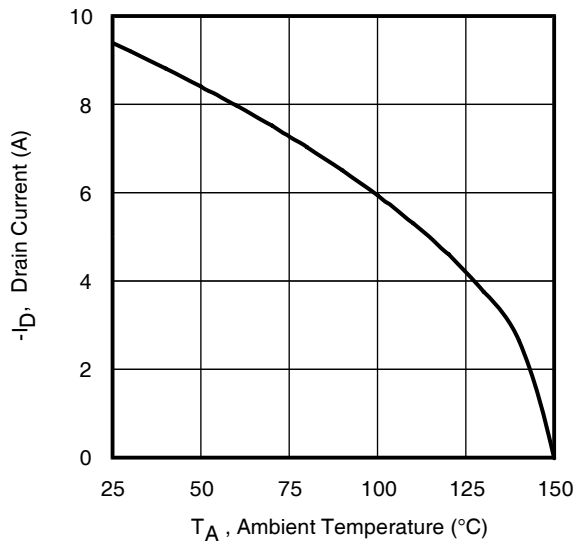
**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage



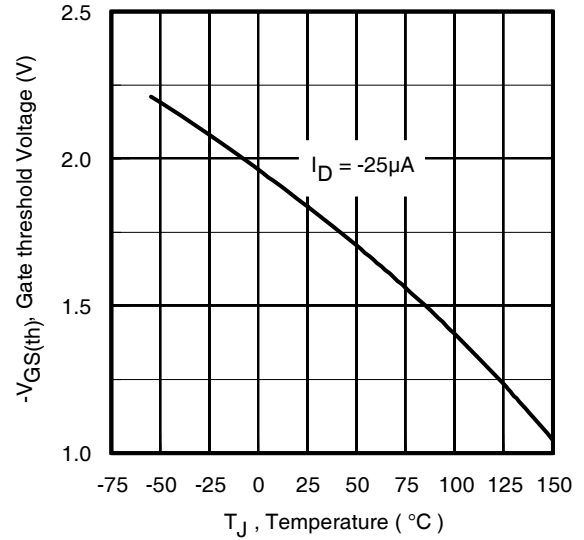
**Fig 7.** Typical Source-Drain Diode Forward Voltage



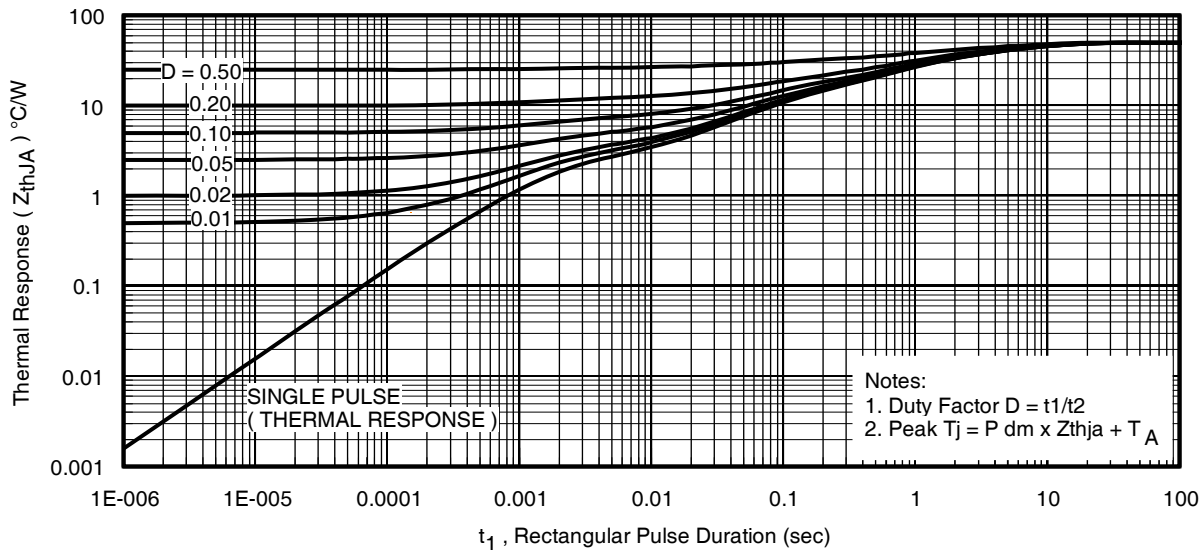
**Fig 8.** Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current vs. Ambient Temperature



**Fig 10.** Threshold Voltage vs. Temperature



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

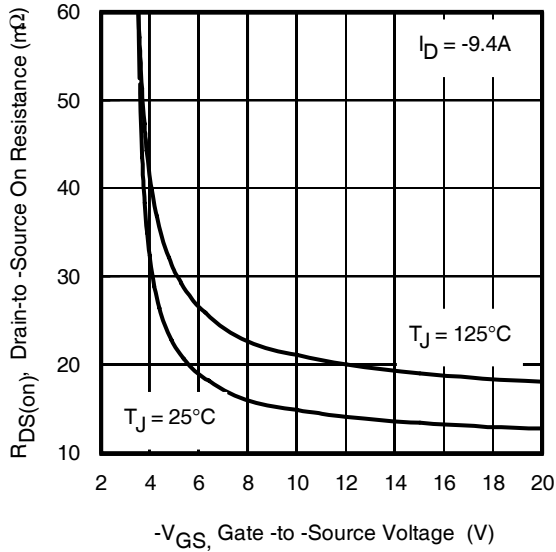


Fig 12. On-Resistance vs. Gate Voltage

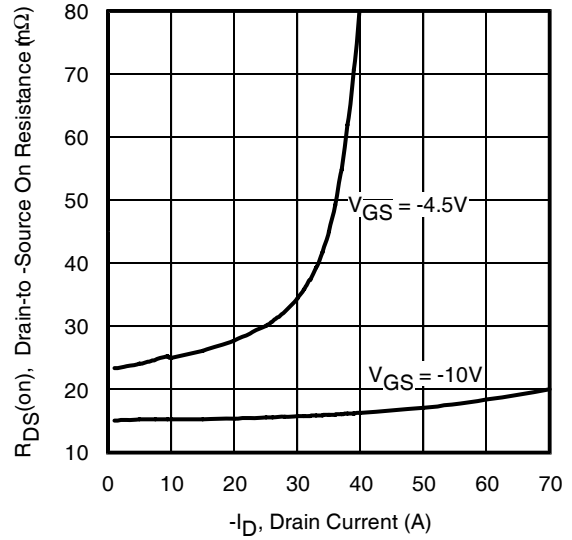


Fig 13. Typical On-Resistance vs. Drain Current

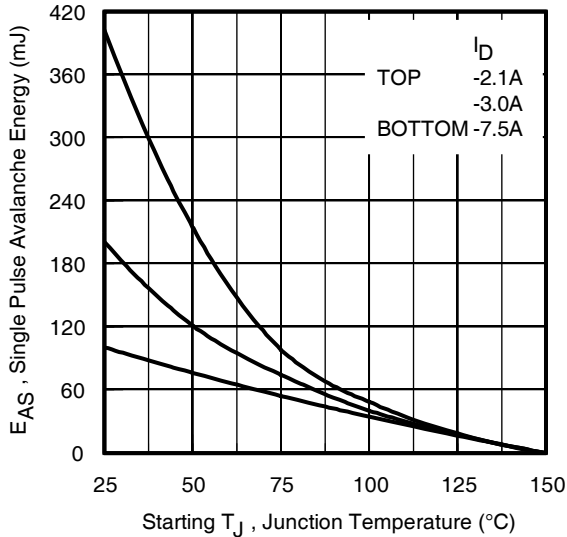


Fig 14. Maximum Avalanche Energy vs. Drain Current

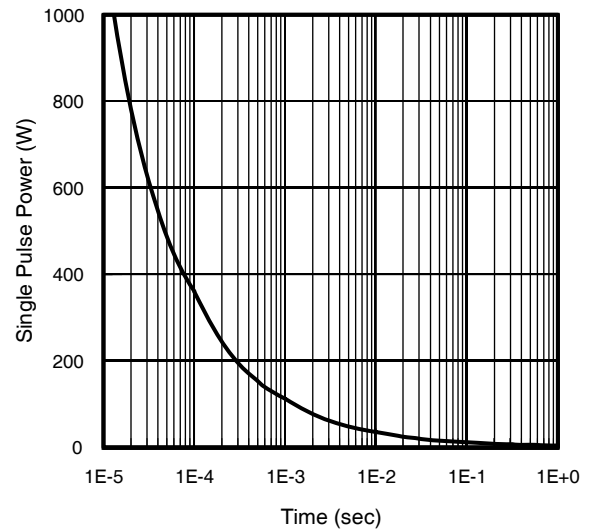
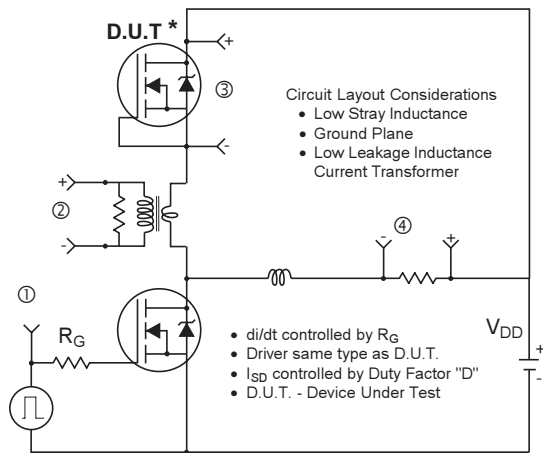
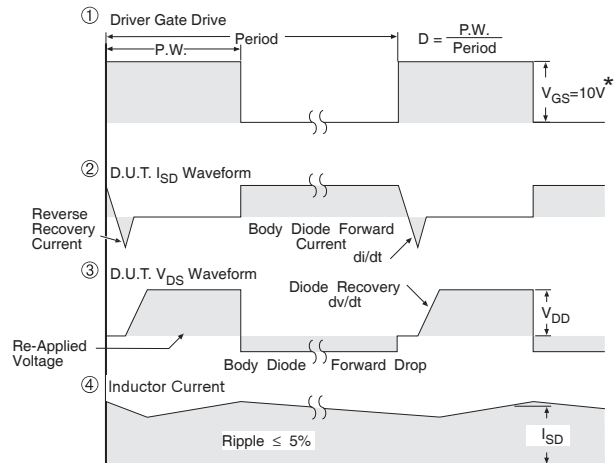


Fig 16. Typical Power vs. Time

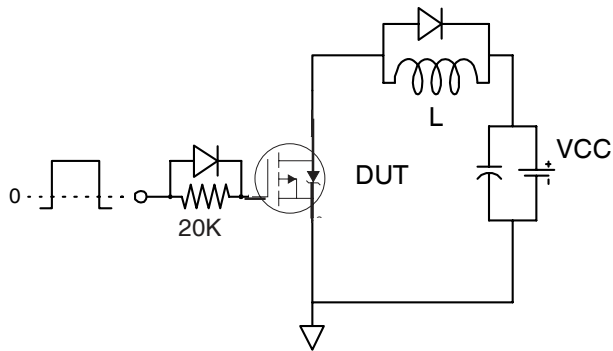


\* Reverse Polarity of D.U.T. for P-Channel

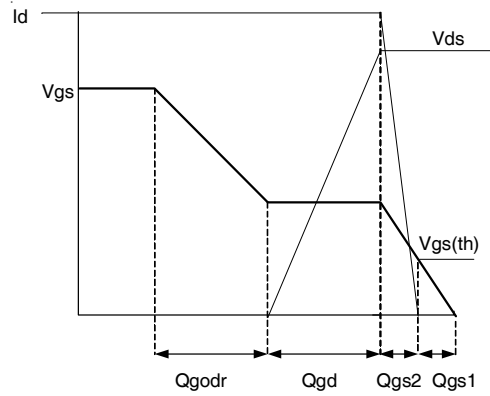


\*  $V_{GS} = 5V$  for Logic Level Devices

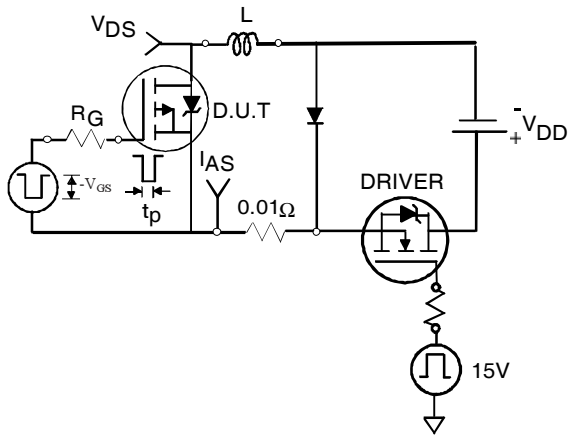
Fig 17. Diode Reverse Recovery Test Circuit for P-Channel HEXFET® Power MOSFETs



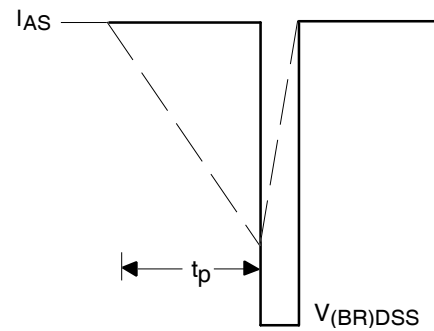
**Fig 18a.** Gate Charge Test Circuit



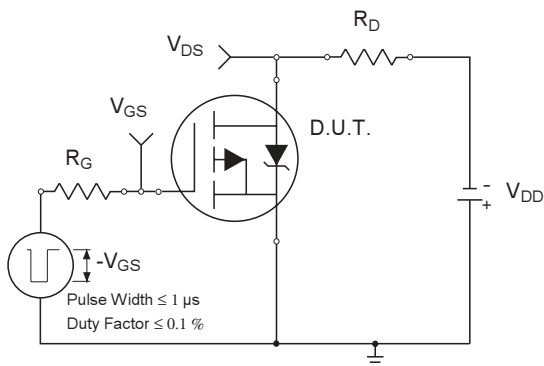
**Fig 18b.** Gate Charge Waveform



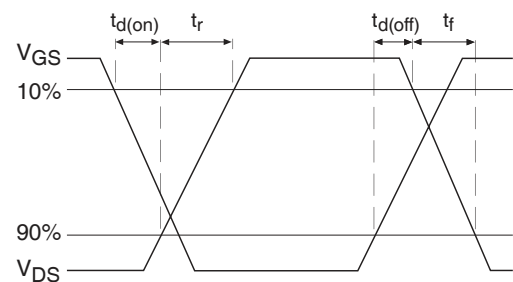
**Fig 19a.** Unclamped Inductive Test Circuit



**Fig 19b.** Unclamped Inductive Waveforms



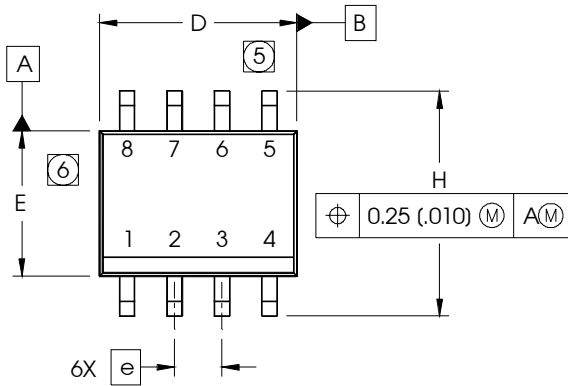
**Fig 20a.** Switching Time Test Circuit



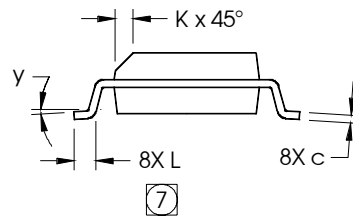
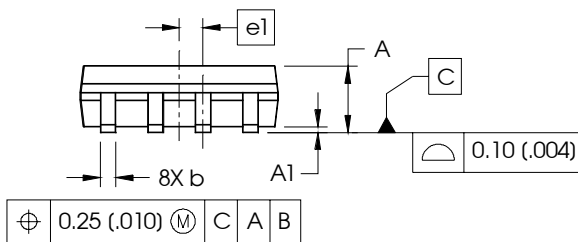
**Fig 20b.** Switching Time Waveforms

## SO-8 Package Outline (MOSFET & Fetky)

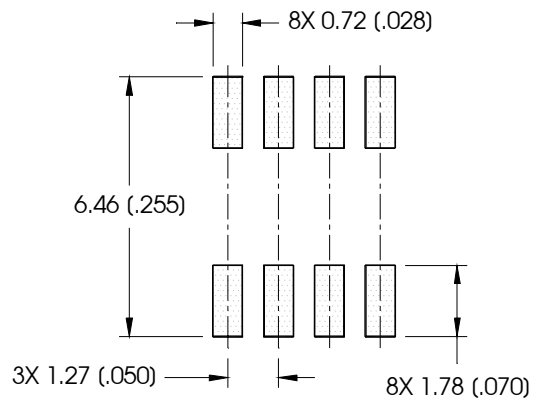
Dimensions are shown in millimeters (inches)



| DIM | INCHES     |       | MILLIMETERS |      |
|-----|------------|-------|-------------|------|
|     | MIN        | MAX   | MIN         | MAX  |
| A   | .0532      | .0688 | 1.35        | 1.75 |
| A1  | .0040      | .0098 | 0.10        | 0.25 |
| b   | .013       | .020  | 0.33        | 0.51 |
| c   | .0075      | .0098 | 0.19        | 0.25 |
| D   | .189       | .1968 | 4.80        | 5.00 |
| E   | .1497      | .1574 | 3.80        | 4.00 |
| e   | .050 BASIC |       | 1.27 BASIC  |      |
| e1  | .025 BASIC |       | 0.635 BASIC |      |
| H   | .2284      | .2440 | 5.80        | 6.20 |
| K   | .0099      | .0196 | 0.25        | 0.50 |
| L   | .016       | .050  | 0.40        | 1.27 |
| y   | 0°         | 8°    | 0°          | 8°   |



### FOOTPRINT

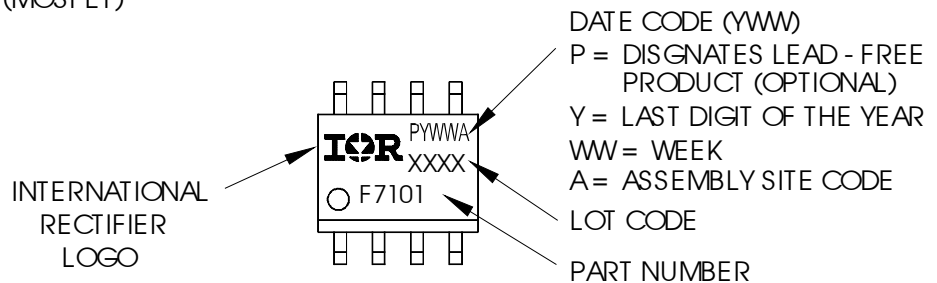


### NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- ⑤ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 (.006).
- ⑥ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.010).
- ⑦ DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

## SO-8 Part Marking Information

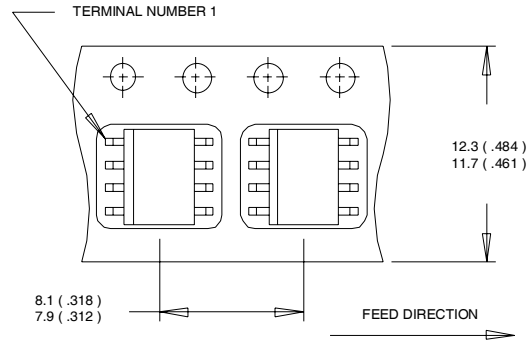
EXAMPLE: THIS IS AN IRF7101 (MOSFET)



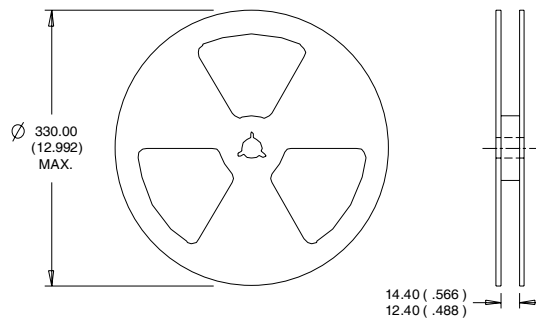
Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

# IRF9393PbF

SO-8 Tape and Reel (Dimensions are shown in millimeters (inches))



- NOTES:
1. CONTROLLING DIMENSION : MILLIMETER.
  2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
  3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
  2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

## Qualification Information<sup>†</sup>

|                            |   |  |
|----------------------------|---|--|
| Qualification level        | Consumer <sup>††</sup>                        |  |
|                            | (per JEDEC JESD47F <sup>†††</sup> guidelines) |  |
| Moisture Sensitivity Level | SO-8  | MSL1<br>(per JEDEC J-STD-020D <sup>†††</sup> ) |
| RoHS Compliant             | Yes   |  |

† Qualification standards can be found at International Rectifier's web site  
<http://www.irf.com/product-info/reliability>

†† Higher qualification ratings may be available should the user have such requirements.  
Please contact your International Rectifier sales representative for further information:  
<http://www.irf.com/whoto-call/salesrep/>

††† Applicable version of JEDEC standard at the time of product release.

Data and specifications subject to change without notice.



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